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Silicon N Channel Power MOS FET with Schottky Barrier Diode High Speed Power Switching



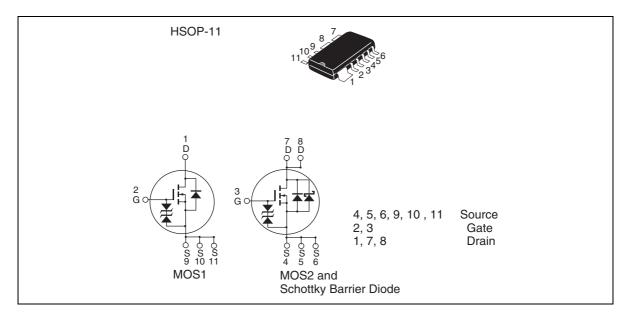
ADE-208-1576D (Z)

5th. Edition Dec. 2002

#### Features

- Low on-resistance
- Capable of 4.5 V gate drive
- High density mounting
- Built-in Schottky Barrier Diode

#### Outline



#### **Absolute Maximum Ratings**

 $(Ta = 25^{\circ}C)$ 

Item	Symbol	Ratings		Unit
		MOS1	MOS2 & SBD	
Drain to source voltage	V <sub>DSS</sub>	30	30	V
Gate to source voltage	V <sub>GSS</sub>	±20	±12	V
Drain current	I <sub>D</sub>	12	16	A
Drain peak current	Note1 D(pulse)	96	128	A
Reverse drain current	I <sub>DR</sub>	12	16	A
Channel dissipation	Pch <sup>Note2</sup>	2.0	3.5	W
Channel temperature	Tch	150	150	°C
Storage temperature	Tstg	-55 to +150	–55 to +150	°C

Notes: 1.  $PW \le 10\mu s$ , duty cycle  $\le 1 \%$ 

2. 1 Drive operation; When using the glass epoxy board (FR4 40 x 40 x 1.6 mm), PW  $\leq$  10s

### **Electrical Characteristics**

 $(Ta = 25^{\circ}C)$ 

#### • MOS1

Item	Symbol	Min	Тур	Max	Unit	Test Conditions
Drain to source breakdown voltage	V <sub>(BR)DSS</sub>	30	_		V	$I_{_{D}} = 10 \text{mA}, V_{_{GS}} = 0$
Gate to source breakdown voltage	$V_{\rm (BR)GSS}$	±20	_		V	$I_{_G}=\pm100\mu A,\ V_{_{DS}}=0$
Gate to source leak current	I <sub>GSS</sub>	_	_	±10	μΑ	$V_{_{\rm GS}} = \pm 16V, V_{_{\rm DS}} = 0$
Zero gate voltage drain current	I <sub>DSS</sub>	_	_	1	μΑ	$V_{_{\rm DS}} = 30V, V_{_{\rm GS}} = 0$
Gate to source cutoff voltage	$V_{GS(off)}$	1.0	_	2.5	V	$V_{_{DS}} = 10V, I_{_{D}} = 1mA$
Static drain to source on state	$R_{DS(on)}$	_	10	13	mΩ	$I_{D} = 6A, V_{GS} = 10V^{Note3}$
resistance	$R_{DS(on)}$		18	27	mΩ	$I_{\rm D} = 6A, V_{\rm GS} = 4.5V^{\rm Note3}$
Forward transfer admittance	ly <sub>fs</sub> l	12	20		S	$I_{D} = 6A, V_{DS} = 10V^{Note3}$
Input capacitance	Ciss	—	1000		рF	$V_{\rm DS} = 10V$
Output capacitance	Coss	—	280		рF	$V_{gs} = 0$
Reverse transfer capacitance	Crss		160		pF	f = 1MHz
Total gate charge	Qg		9		nc	$V_{dd} = 10 V$
Gate to source charge	Qgs		3.6		nc	$V_{gs} = 5 V$
Gate to drain charge	Qgd	—	3.2		nc	$I_{D} = 16 \text{ A}$
Turn-on delay time	t <sub>d(on)</sub>	—	12		ns	$V_{_{\rm GS}} = 10V, I_{_{\rm D}} = 6A$
Rise time	t,		22		ns	$V_{\text{DD}} \approx 10V$
Turn-off delay time	t <sub>d(off)</sub>		55		ns	$R_{L} = 1.67\Omega$
Fall time	t,	—	9		ns	$R_g = 4.7\Omega$
Body-drain diode forward voltage	$V_{DF}$	—	0.82	1.07	V	$IF = 12A, V_{GS} = 0^{Note3}$
Body–drain diode reverse recovery time	t <sub>rr</sub>	—	25		ns	IF =12A, V <sub>GS</sub> = 0 diF/ dt =50A/µs

Notes: 3. Pulse test

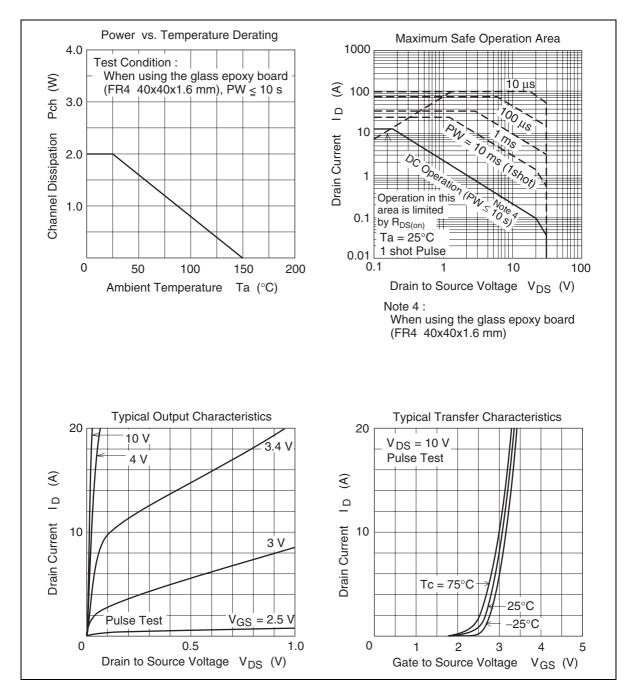
#### • MOS2 & Schottky Barrier Diode

Item	Symbol	Min	Тур	Max	Unit	Test Conditions
Drain to source breakdown voltage	$V_{\scriptscriptstyle (BR)DSS}$	30		_	V	$I_{_{D}} = 10 \text{mA}, V_{_{\mathrm{GS}}} = 0$
Gate to source breakdown voltage	$V_{\rm (BR)GSS}$	±12		_	V	$I_{_{G}} = \pm 100 \mu A, V_{_{DS}} = 0$
Gate to source leak current	I <sub>GSS</sub>		_	±10	μA	$V_{_{\rm GS}} = \pm 10V, V_{_{\rm DS}} = 0$
Zero gate voltage drain current	I <sub>DSS</sub>	—		1	m A	$V_{_{\rm DS}} = 30V, V_{_{\rm GS}} = 0$
Gate to source cutoff voltage	$V_{\text{GS(off)}}$	1.4	_	2.5	V	$V_{_{DS}} = 10V, I_{_{D}} = 1mA$
Static drain to source on state	$R_{\scriptscriptstyle DS(\text{on})}$		5.6	7.3	mΩ	$I_{D} = 8A, V_{GS} = 10V^{Note3}$
resistance	$R_{DS(on)}$	—	7.3	9.5	mΩ	$I_{D} = 8A, V_{GS} = 4.5V^{Note3}$
Forward transfer admittance	ly <sub>fs</sub> l	25	41	_	S	$I_{\rm D} = 8A, V_{\rm DS} = 10V^{\rm Note3}$
Input capacitance	Ciss		3800		pF	$V_{\rm DS} = 10V$
Output capacitance	Coss	—	745	—	pF	$V_{gs} = 0$
Reverse transfer capacitance	Crss	_	300	_	pF	f = 1MHz
Total gate charge	Qg		34		nc	$V_{dD} = 10 V$
Gate to source charge	Qgs	_	10	_	nc	$V_{gs} = 5 V$
Gate to drain charge	Qgd	_	8	_	nc	I <sub>D</sub> = 16 A
Turn-on delay time	t <sub>d(on)</sub>		18		ns	$V_{_{\rm GS}} = 10V, I_{_{\rm D}} = 8A$
Rise time	t,	—	22	_	ns	$V_{\text{DD}} \approx 10V$
Turn-off delay time	t <sub>d(off)</sub>	—	88	_	ns	$R_{L} = 1.25\Omega$
Fall time	t,	_	9.0	_	ns	$R_g = 4.7\Omega$
Schottky Barrier diode forward voltage	$V_{F}$	—	0.5	—	V	$IF = 3.5A, V_{GS} = 0^{Note3}$
Body-drain diode reverse recovery time	t <sub>rr</sub>	—	35	—	ns	IF = 16A, V <sub>GS</sub> = 0 diF/ dt =50A/µs
Notes: 3 Pulse test						

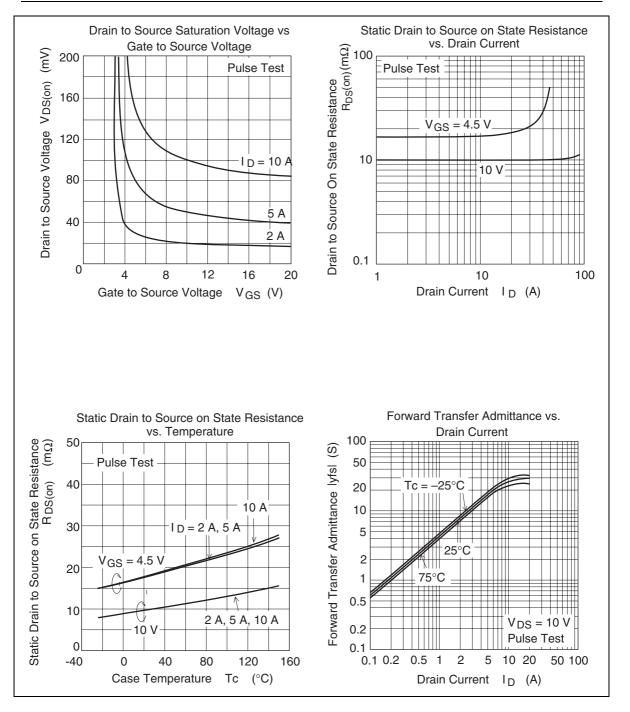
Notes: 3. Pulse test

#### **Main Characteristics**

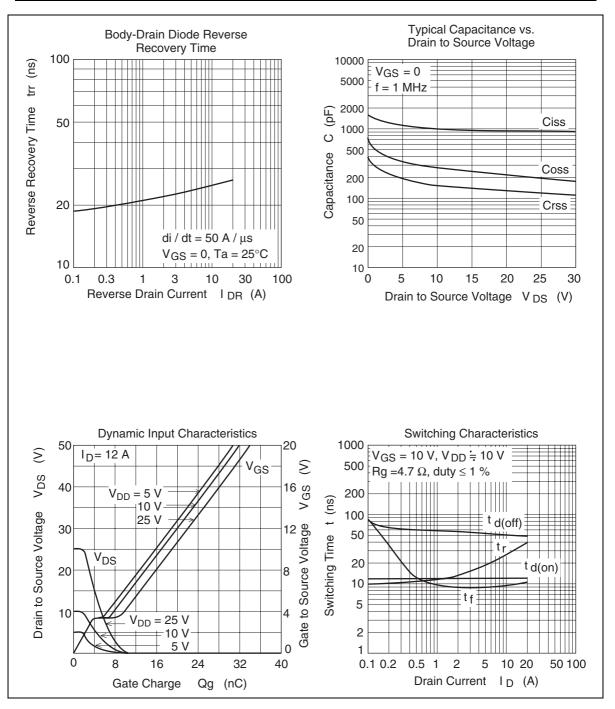
#### • MOS1

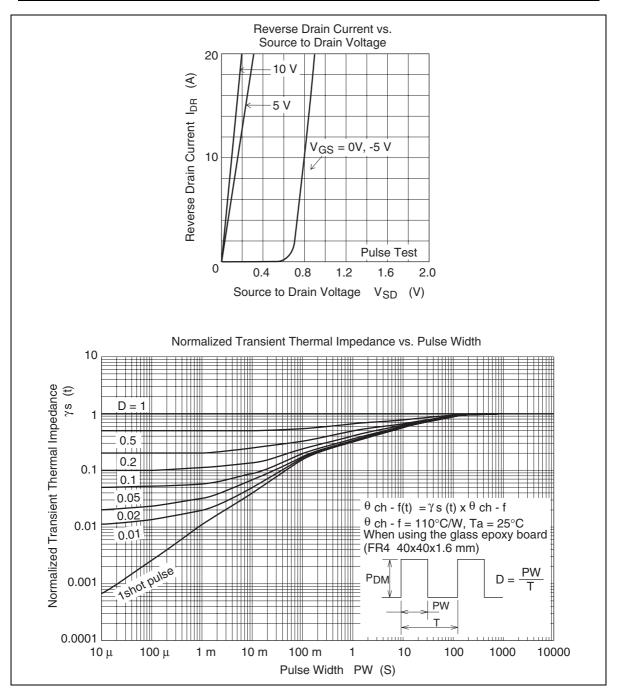


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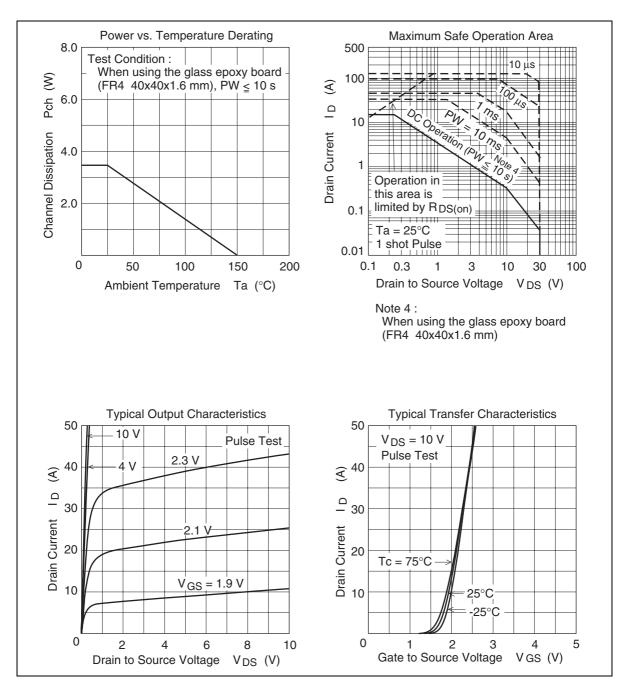
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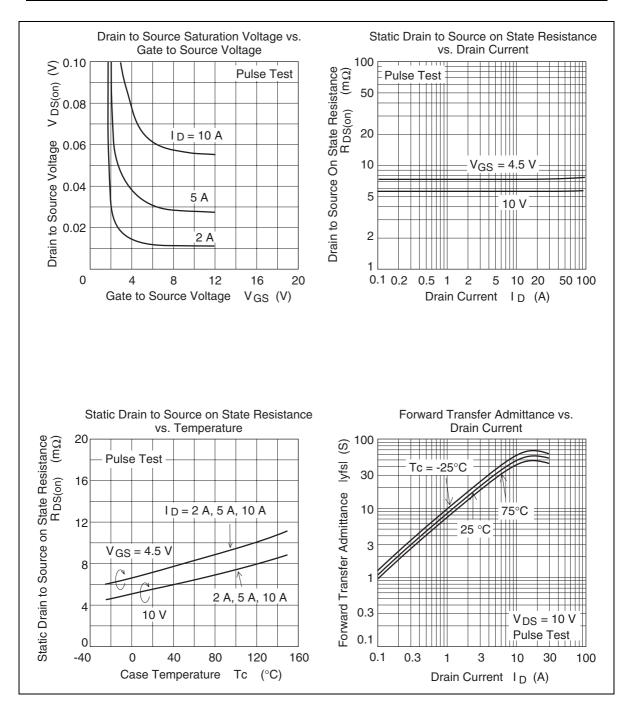


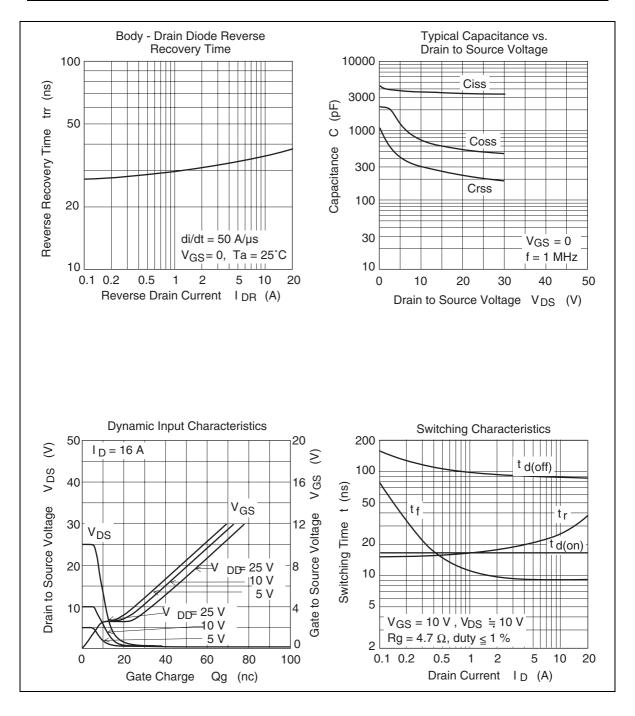
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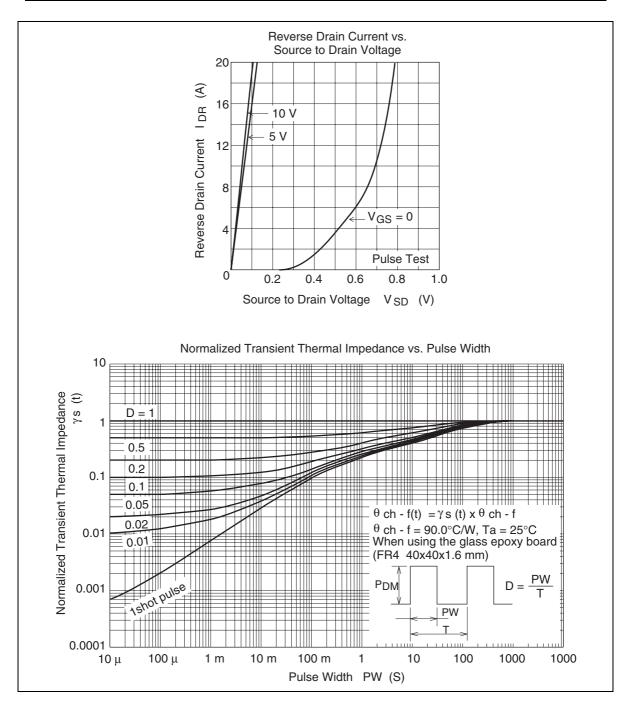
#### • MOS2 & Schottky Barrier Diode



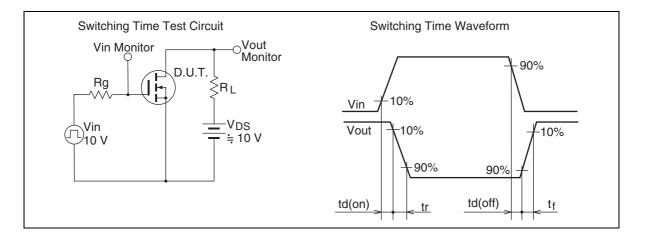
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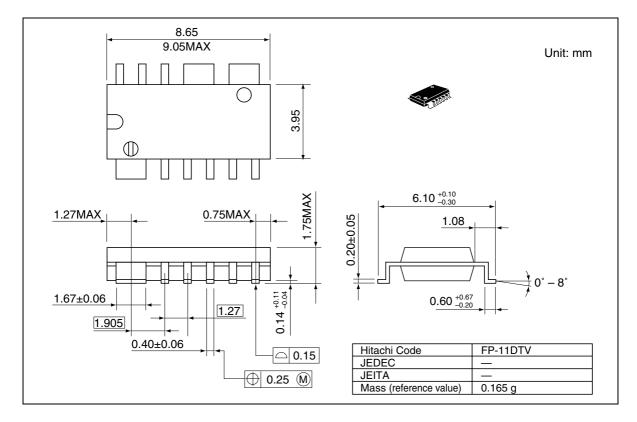


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## **Package Dimensions**





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